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"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	56800EX
Core Size	32-Bit Single-Core
Speed	60MHz
Connectivity	CANbus, I²C, LINbus, SCI, SPI
Peripherals	Brown-out Detect/Reset, DMA, LVD, POR, PWM, WDT
Number of I/O	54
Program Memory Size	64KB (64K x 8)
Program Memory Type	FLASH
EEPROM Size	2K x 8
RAM Size	8K x 8
Voltage - Supply (Vcc/Vdd)	3V ~ 3.6V
Data Converters	A/D 16x12b, 8x16b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	64-LQFP
Supplier Device Package	64-LQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mc56f84442vlh

1 Overview

1.1 MC56F844x/5x/7x Product Family

The following table highlights major features, including features that differ among members of the family. Features not listed are shared by all members of the family.

Table 1. 56F844x/5x/7x Family

Part Number	MC56F84																	
	789	**786**	**769**	**766**	**763**	**553**	**550**	**543**	**540**	**587**	**585**	**567**	**565**	**462**	**452**	**451**	**442**	**441**
Core frequency (MHz)	100	100	100	100	100	80	80	80	80	80	80	80	80	60	60	60	60	60
Flash memory (KB)	256	256	128	128	128	96	96	64	64	256	256	128	128	128	96	96	64	64
FlevNVM/ FlexRAM (KB)	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2	32/2
Total flash memory, including FlexNVM (KB)[1]	288	288	160	160	160	128	128	96	96	288	288	160	160	160	128	128	96	96
RAM (KB)	32	32	24	24	24	16	16	8	8	32	32	24	24	24	16	16	8	8
Memory resource protection	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
External Watchdog	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1
12-bit Cyclic ADC channels	2x8 (300 ns)	2x8 (300 ns)	2x8 (300 ns)	2x8 (300 ns)	2x8 (300 ns)	2x8 (300 ns)	2x5 (300 ns)	2x8 (300 ns)	2x5 (300 ns)	2x8 (600 ns)	2x8 (600 ns)	2x8 (600 ns)	2x8 (600 ns)	2x8 (600 ns)	2x8 (600 ns)	2x5 (600 ns)	2x8 (600 ns)	2x5 (600 ns)
16-bit SAR ADC (with Temp Sensor) channels	1x 16	1x 10	1x 16	1x 10	1x8	1x8	0	1x8	0	1x 16	1x 10	1x 16	1x 10	0	1x8	0	1x8	0
PWMA with input capture:																		
High-resolution channels	1x8	1x8	1x8	1x8	1x8	1x8	1x6	1x8	1x6	0	0	0	0	0	0	0	0	0

Table continues on the next page...

Table 1. 56F844x/5x/7x Family (continued)

Part Number	MC56F84																	
	789	786	769	766	763	553	550	543	540	587	585	567	565	462	452	451	442	441
Standard channels	4	1	4	1	1	1	0	1	0	2x 12	1x 12, 1x9	2x 12	1x 12, 1x9	1x9	1x9	1x6	1x9	1x6
PWMB with input capture: Standard channels	1x 12	1x7	1x 12	1x7	0	0	0	0	0	0	0	0	0	0	0	0	0	0
DAC	1	1	1	1	1	1	1	1	1	1	1	0	0	1	0	0	0	0
Quad Decoder	1	1	1	1	0	0	0	0	0	1	1	1	1	1	1	1	1	1
DMA	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes	Yes
CMP	4	4	4	4	4	4	3	4	3	4	4	4	4	4	4	3	4	3
QSCI	3	3	3	3	2	2	2	2	2	3	3	3	3	2	2	2	2	2
QSPI	3	2	3	2	2	2	2	2	2	3	2	3	2	2	2	2	2	2
I2C/SMBus	2	2	2	2	2	2	2	2	2	2	2	2	2	2	2	2	2	2
FlexCAN	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	0	0
LQFP package pin count	100	80	100	80	64	64	48	64	48	100	80	100	80	64	64	48	64	48

1. This total assumes no FlexNVM is used with FlexRAM for EEPROM.

1.2 56800EX 32-bit Digital Signal Controller Core

- Efficient 32-bit 56800EX Digital Signal Processor (DSP) engine with modified dual Harvard architecture
  - Three internal address buses
  - Four internal data buses: two 32-bit primary buses, one 16-bit secondary data bus, and one 16-bit instruction bus
  - 32-bit data accesses
  - Support for concurrent instruction fetches in the same cycle and dual data accesses in the same cycle
  - 20 addressing modes
- As many as 60 million instructions per second (MIPS) at 60 MHz core frequency
- 162 basic instructions
- Instruction set supports both fractional arithmetic and integer arithmetic
- 32-bit internal primary data buses supporting 8-bit, 16-bit, and 32-bit data movement, addition, subtraction, and logical operation
- Single-cycle 16 × 16-bit -> 32-bit and 32 x 32-bit -> 64-bit multiplier-accumulator (MAC) with dual parallel moves

1.6.7 Queued Serial Communications Interface (QSCI) Modules

- Operating clock up to two times CPU operating frequency
- Four-word-deep FIFOs available on both transmit and receive buffers
- Standard mark/space non-return-to-zero (NRZ) format
- 13-bit integer and 3-bit fractional baud rate selection
- Full-duplex or single-wire operation
- Programmable 8-bit or 9-bit data format
- Error detection capability
- Two receiver wakeup methods:
  - Idle line
  - Address mark
- 1/16 bit-time noise detection

1.6.8 Queued Serial Peripheral Interface (QSPI) Modules

- Maximum 25 Mbps baud rate
- Selectable baud rate clock sources for low baud rate communication
- Baud rate as low as Baudrate_Freq_in / 8192
- Full-duplex operation
- Master and slave modes
- Double-buffered operation with separate transmit and receive registers
- Four-word-deep FIFOs available on transmit and receive buffers
- Programmable length transmissions (2 bits to 16 bits)
- Programmable transmit and receive shift order (MSB as first bit transmitted)

1.6.9 Inter-Integrated Circuit (I2C)/System Management Bus (SMBus) Modules

- Compatible with I2C bus standard
- Support for System Management Bus (SMBus) specification, version2
- Multi-master operation
- General call recognition
- 10-bit address extension
- Dual slave addresses
- Programmable glitch input filter

1.6.10 Flex Controller Area Network (FlexCAN) Module

- Clock source from PLL or XOSC/CLKIN

- Implementation of the CAN protocol Version 2.0 A/B
- Standard and extended data frames
- 0-to-8 bytes data length
- Programmable bit rate up to 1 Mbps
- Support for remote frames
- Sixteen Message Buffers, each configurable as receive or transmit, all supporting standard and extended messages
- Individual Rx Mask Registers per Message Buffer
- Internal timer for time-stamping of received and transmitted messages
- Listen-only mode capability
- Programmable loopback mode supporting self-test operation
- Programmable transmission priority scheme: lowest ID, lowest buffer number, or highest priority
- Global network time, synchronized by a specific message
- Low power modes, with programmable wakeup on bus activity

1.6.11 Computer Operating Properly (COP) Watchdog

- Programmable timeout period
- Support for operation in all power modes: run mode, wait mode, stop mode
- Causes loss of reference reset 128 cycles after loss of reference clock to the PLL is detected
- Selectable reference clock source in support of EN60730 and IEC61508
- Selectable clock sources:
  - External crystal oscillator/external clock source
  - On-chip low-power 32 kHz oscillator
  - System bus (IPBus up to 60 MHz)
  - 8 MHz / 400 kHz ROSC
- Support for interrupt triggered when the counter reaches the timeout value

1.6.12 Power Supervisor

- Power-on reset (POR) to reset CPU, peripherals, and JTAG/EOnCE controllers (VDD > 2.1 V)
- Brownout reset (VDD < 1.9 V)
- Critical warn low voltage interrupt (LVI2.0)
- Peripheral low voltage interrupt (LVI2.7)

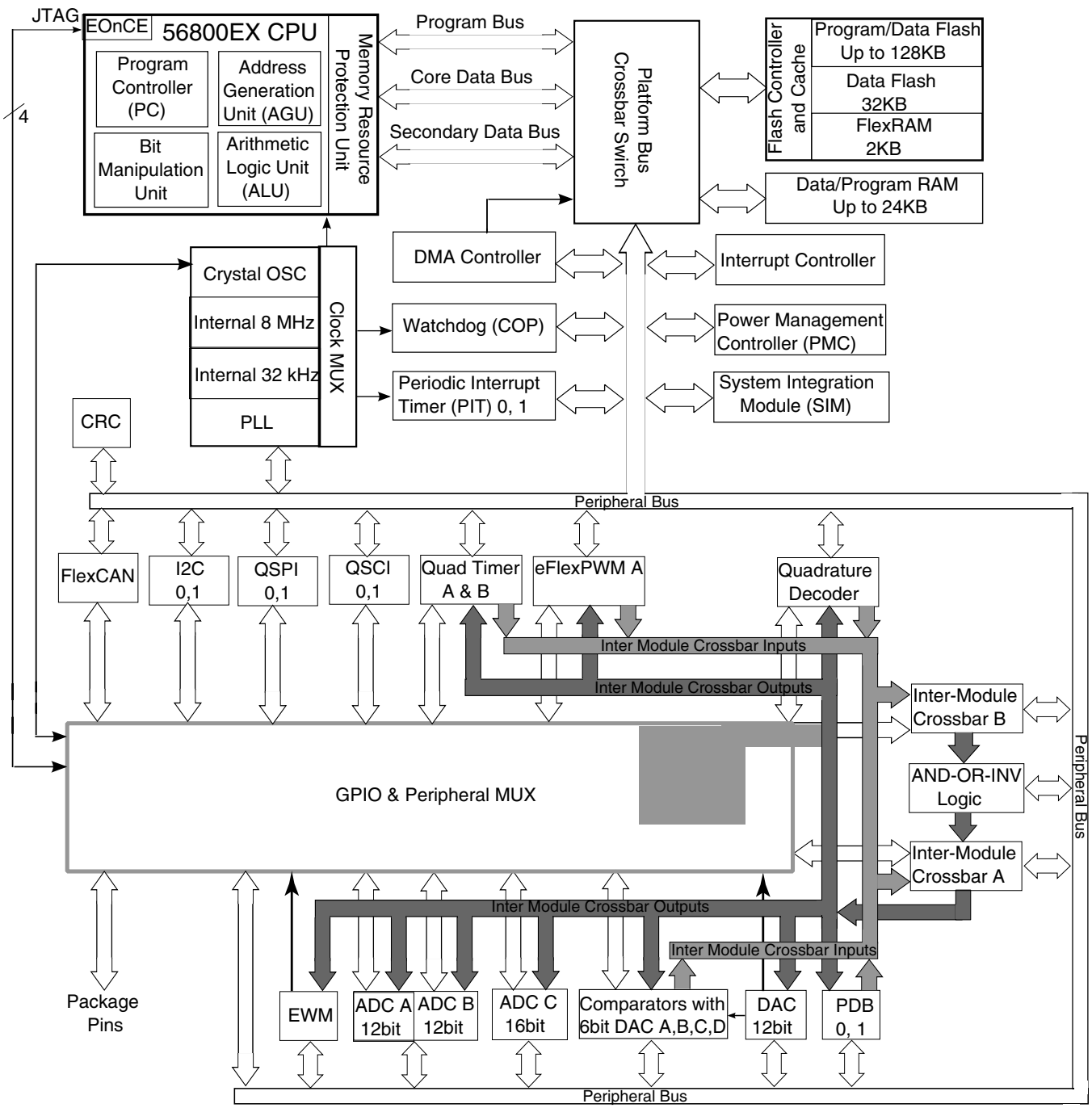

Figure 2. System Diagram

2 Signal groups

The input and output signals of the MC56F84xxx are organized into functional groups, as detailed in Table 2.

Table 2. Functional Group Pin Allocations

Functional Group	Number of Pins in 48LQFP	Number of Pins in 64LQFP	Number of Pins in 80LQFP	Number of Pins in 100LQFP
Power Inputs (V_{DD}, V_{DDA}, V_{CAP})	5	6	6	6
Ground (V_{SS}, V_{SSA})	4	4	4	4
Reset	1	1	1	1
eFlexPWM ports, not including fault pins	6	9	N/A	N/A
Queued Serial Peripheral Interface (QSPI) ports	5	6	8	15
Queued Serial Communications Interface (QSCI) ports	6	9	13	15
Inter-Integrated Circuit (I^2C) interface ports	4	6	6	6
12-bit Analog-to-Digital Converter (Cyclic ADC) inputs	10	16	16	16
16-bit Analog-to-Digital Converter (SAR ADC) inputs	2	8	10	16
Analog Comparator inputs/outputs	10/4	13/6	13/6	16/6
12-bit Digital-to-Analog output	1	1	1	1
Quad Timer Module (TMR) ports	6	9	11	13
Controller Area Network (FlexCAN)	2	2	2	2
Inter-Module Crossbar inputs/outputs	12/2	16/6	19/17	25/19
Clock inputs/outputs	2/2	2/2	2/3	2/3
JTAG / Enhanced On-Chip Emulation (EOnCE)	4	4	4	4

3 Ordering parts

3.1 Determining valid orderable parts

Valid orderable part numbers are provided on the web. To determine the orderable part numbers for this device, go to www.freescale.com and perform a part number search for the following device numbers: MC56F84

4 Part identification

4.1 Description

Part numbers for the chip have fields that identify the specific part. You can use the values of these fields to determine the specific part you have received.

4.2 Format

Part numbers for this device have the following format: Q 56F8 4 C F P T PP N

4.3 Fields

This table lists the possible values for each field in the part number (not all combinations are valid):

Field	Description	Values
Q	Qualification status	• MC = Fully qualified, general market flow • PC = Prequalification
56F8	DSC family with flash memory and DSP56800/ DSP56800E/DSP56800EX core	• 56F8
4	DSC subfamily	• 4
C	Maximum CPU frequency (MHz)	• 4 = 60 MHz • 5 = 80 MHz • 7 = 100 MHz
F	Primary program flash memory size	• 4 = 64 KB • 5 = 96 KB • 6 = 128 KB • 8 = 256 KB
P	Pin count	• 0 and 1 = 48 • 2 and 3 = 64 • 4, 5, and 6 = 80 • 7, 8, and 9 = 100
T	Temperature range (°C)	• V = –40 to 105
PP	Package identifier	• LF = 48LQFP • LH = 64LQFP • LK = 80LQFP • LL = 100LQFP
N	Packaging type	• R = Tape and reel • (Blank) = Trays

4.4 Example

This is an example part number: MC56F84789VLL

5 Terminology and guidelines

5.1 Definition: Operating requirement

An *operating requirement* is a specified value or range of values for a technical characteristic that you must guarantee during operation to avoid incorrect operation and possibly decreasing the useful life of the chip.

5.1.1 Example

This is an example of an operating requirement, which you must meet for the accompanying operating behaviors to be guaranteed:

Symbol	Description	Min.	Max.	Unit
V_{DD}	1.0 V core supply voltage	0.9	1.1	V

5.2 Definition: Operating behavior

An *operating behavior* is a specified value or range of values for a technical characteristic that are guaranteed during operation if you meet the operating requirements and any other specified conditions.

5.2.1 Example

This is an example of an operating behavior, which is guaranteed if you meet the accompanying operating requirements:

Symbol	Description	Min.	Max.	Unit
I_{WP}	Digital I/O weak pullup/ pulldown current	10	130	µA

5.3 Definition: Attribute

An *attribute* is a specified value or range of values for a technical characteristic that are guaranteed, regardless of whether you meet the operating requirements.

5.3.1 Example

This is an example of an attribute:

Symbol	Description	Min.	Max.	Unit
CIN_D	Input capacitance: digital pins	—	7	pF

5.4 Definition: Rating

A *rating* is a minimum or maximum value of a technical characteristic that, if exceeded, may cause permanent chip failure:

- *Operating ratings* apply during operation of the chip.
- *Handling ratings* apply when the chip is not powered.

5.4.1 Example

This is an example of an operating rating:

Symbol	Description	Min.	Max.	Unit
V_{DD}	1.0 V core supply voltage	–0.3	1.2	V

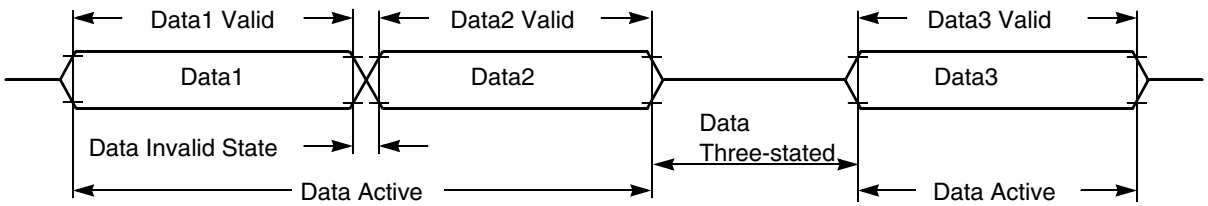

Figure 4. Signal States

7.3 Nonswitching electrical specifications

7.3.1 Voltage and current operating requirements

This section includes information about recommended operating conditions.

NOTE

Recommended V_{DD} ramp rate is between 1 ms and 200 ms.

Table 5. Recommended Operating Conditions (V_{REFLx} = 0 V, V_{SSA} = 0 V, V_{SS} = 0 V)

Characteristic	Symbol	Notes[1]	Min	Typ	Max	Unit
Supply voltage[2]	V_{DD}, V_{DDA}		2.7	3.3	3.6	V
ADC (Cyclic) Reference Voltage High	V_{REFHA} V_{REFHB}		3.0		V_{DDA}	V
ADC (SAR) Reference Voltage High	V_{REFHC}		2.0		V_{DDA}	V
Voltage difference V_{DD} to V_{DDA}	ΔVDD		-0.1	0	0.1	V
Voltage difference V_{SS} to V_{SSA}	ΔVSS		-0.1	0	0.1	V
Input Voltage High (digital inputs)	V_{IH}	Pin Groups 1, 2	0.7 x V_{DD}		5.5	V
Input Voltage Low (digital inputs)	V_{IL}	Pin Groups 1, 2			0.35 x V_{DD}	V
Oscillator Input Voltage High XTAL driven by an external clock source	V_{IHOSC}	Pin Group 4	2.0		V_{DD} + 0.3	V
Oscillator Input Voltage Low	V_{ILOSC}	Pin Group 4	-0.3		0.8	V
Output Source Current High (at V_{OH} min.)[3] • Programmed for low drive strength • Programmed for high drive strength	I_{OH}	 Pin Group 1 Pin Group 1	 — —		 -2 -9	mA
Output Source Current Low (at V_{OL} max.)[3] • Programmed for low drive strength • Programmed for high drive strength	I_{OL}	 Pin Groups 1, 2 Pin Groups 1, 2	 — —		 2 9	mA

1. **Default Mode**
   - Pin Group 1: GPIO, TDI, TDO, TMS, TCK
   - Pin Group 2: $\overline{\text{RESET}}$, GPIOA7
   - Pin Group 3: ADC and Comparator Analog Inputs

7.3.5 Power consumption operating behaviors

Table 9. Current Consumption

Mode	Maximum Frequency	Conditions	Typical at 3.3 V, 25°C		Maximum at 3.6 V, 105°C	
			I_{DD}[1]	I_{DDA}	I_{DD}[1]	I_{DDA}
RUN	60 MHz	• 60 MHz Device Clock • Regulators are in full regulation • Relaxation Oscillator on • PLL powered on • Continuous MAC instructions with fetches from Program Flash • All peripheral modules enabled. • TMRs and SCIs using 1X Clock • NanoEdge within PWMA using 2X clock • ADC/DAC powered on and clocked at 5 MHz[2] • Comparator powered on	TBD	TBD	TBD	TBD
WAIT	60 MHz	• 60 MHz Device Clock • Regulators are in full regulation • Relaxation Oscillator on • PLL powered on • Processor Core in WAIT state • All Peripheral modules enabled. • TMRs and SCIs using 1X Clock • NanoEdge within PWMA using 2X clock • ADC/DAC/Comparator powered off	TBD	TBD	TBD	TBD
STOP	4 MHz	• 4 MHz Device Clock • Regulators are in full regulation • Relaxation Oscillator on • PLL powered off • Processor Core in STOP state • All peripheral module and core clocks are off • ADC/DAC/Comparator powered off	TBD	TBD	TBD	TBD
LPRUN (LsRUN)	2 MHz	• 200 kHz Device Clock from Relaxation Oscillator (ROSC) • ROSC in standby mode • Regulators are in standby • PLL disabled • Repeat NOP instructions • All peripheral modules enabled, except NanoEdge and cyclic ADCs[3] • Simple loop with running from platform instruction buffer	TBD	TBD	TBD	TBD
LPWAIT (LsWAIT)	2 MHz	• 200 kHz Device Clock from Relaxation Oscillator (ROSC) • ROSC in standby mode • Regulators are in standby • PLL disabled • All peripheral modules enabled, except NanoEdge and cyclic ADCs[3] • Processor core in wait mode	TBD	TBD	TBD	TBD

Table continues on the next page...

Table 9. Current Consumption (continued)

Mode	Maximum Frequency	Conditions	Typical at 3.3 V, 25°C		Maximum at 3.6 V, 105°C	
			I_{DD}[1]	I_{DDA}	I_{DD}[1]	I_{DDA}
LPSTOP (LsSTOP)	2 MHz	• 200 kHz Device Clock from Relaxation Oscillator (ROSC) • ROSC in standby mode • Regulators are in standby • PLL disabled • Only PITs and COP enabled; other peripheral modules disabled and clocks gated off[3] • Processor core in stop mode	TBD	TBD	TBD	TBD
VLPRUN	200 kHz	• 32 kHz Device Clock • Clocked by a 32 kHz external clock source • Oscillator in power down • All ROSCs disabled • Large regulator is in standby • Small regulator is disabled • PLL disabled • Repeat NOP instructions • All peripheral modules, except COP and EWM, disabled and clocks gated off • Simple loop running from platform instruction buffer	TBD	TBD	TBD	TBD
VLPWAIT	200 kHz	• 32 kHz Device Clock • Clocked by a 32 kHz external clock source • Oscillator in power down • All ROSCs disabled • Large regulator is in standby • Small regulator is disabled • PLL disabled • All peripheral modules, except COP, disabled and clocks gated off • Processor core in wait mode	TBD	TBD	TBD	TBD
VLPSTOP	200 kHz	• 32 kHz Device Clock • Clocked by a 32 kHz external clock source • Oscillator in power down • All ROSCs disabled • Large regulator is in standby • Small regulator is disabled • PLL disabled • All peripheral modules, except COP, disabled and clocks gated off • Processor core in stop mode	TBD	TBD	TBD	TBD

1. No output switching, all ports configured as inputs, all inputs low, no DC loads
2. ADC power consumption at higher frequency can be found in Table 26
3. In all chip LP modes and flash memory VLP modes, the maximum frequency for flash memory operation is 500 kHz due to the fixed frequency ratio of 1:4 between the CPU clock and the flash clock.

1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
2. Determined according to JEDEC Standard JESD51-2, *Integrated Circuits Thermal Test Method Environmental Conditions—Natural Convection (Still Air)* with the single layer board horizontal. For the LQFP, the board meets the JESD51-3 specification.
3. Determined according to JEDEC Standard JESD51-6, *Integrated Circuits Thermal Test Method Environmental Conditions—Forced Convection (Moving Air)* with the board horizontal.
4. Determined according to JEDEC Standard JESD51-8, *Integrated Circuit Thermal Test Method Environmental Conditions—Junction-to-Board*. Board temperature is measured on the top surface of the board near the package.
5. Determined according to Method 1012.1 of MIL-STD 883, *Test Method Standard, Microcircuits*, with the cold plate temperature used for the case temperature. The value includes the thermal resistance of the interface material between the top of the package and the cold plate.
6. Determined according to JEDEC Standard JESD51-2, *Integrated Circuits Thermal Test Method Environmental Conditions—Natural Convection (Still Air)*.

8 Peripheral operating requirements and behaviors

8.1 Core modules

8.1.1 JTAG Timing

Table 15. JTAG Timing

Characteristic	Symbol	Min	Max	Unit	See Figure
TCK frequency of operation	f_{OP}	DC	SYS_CLK/8	MHz	Figure 5
TCK clock pulse width	t_{PW}	50	—	ns	Figure 5
TMS, TDI data set-up time	t_{DS}	5	—	ns	Figure 6
TMS, TDI data hold time	t_{DH}	5	—	ns	Figure 6
TCK low to TDO data valid	t_{DV}	—	30	ns	Figure 6
TCK low to TDO tri-state	t_{TS}	—	30	ns	Figure 6

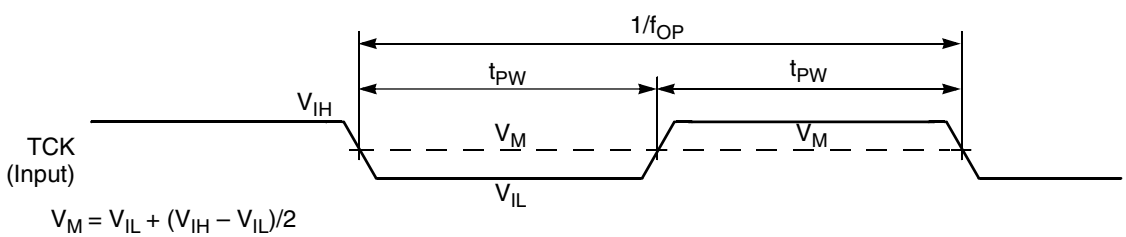

Figure 5. Test Clock Input Timing Diagram

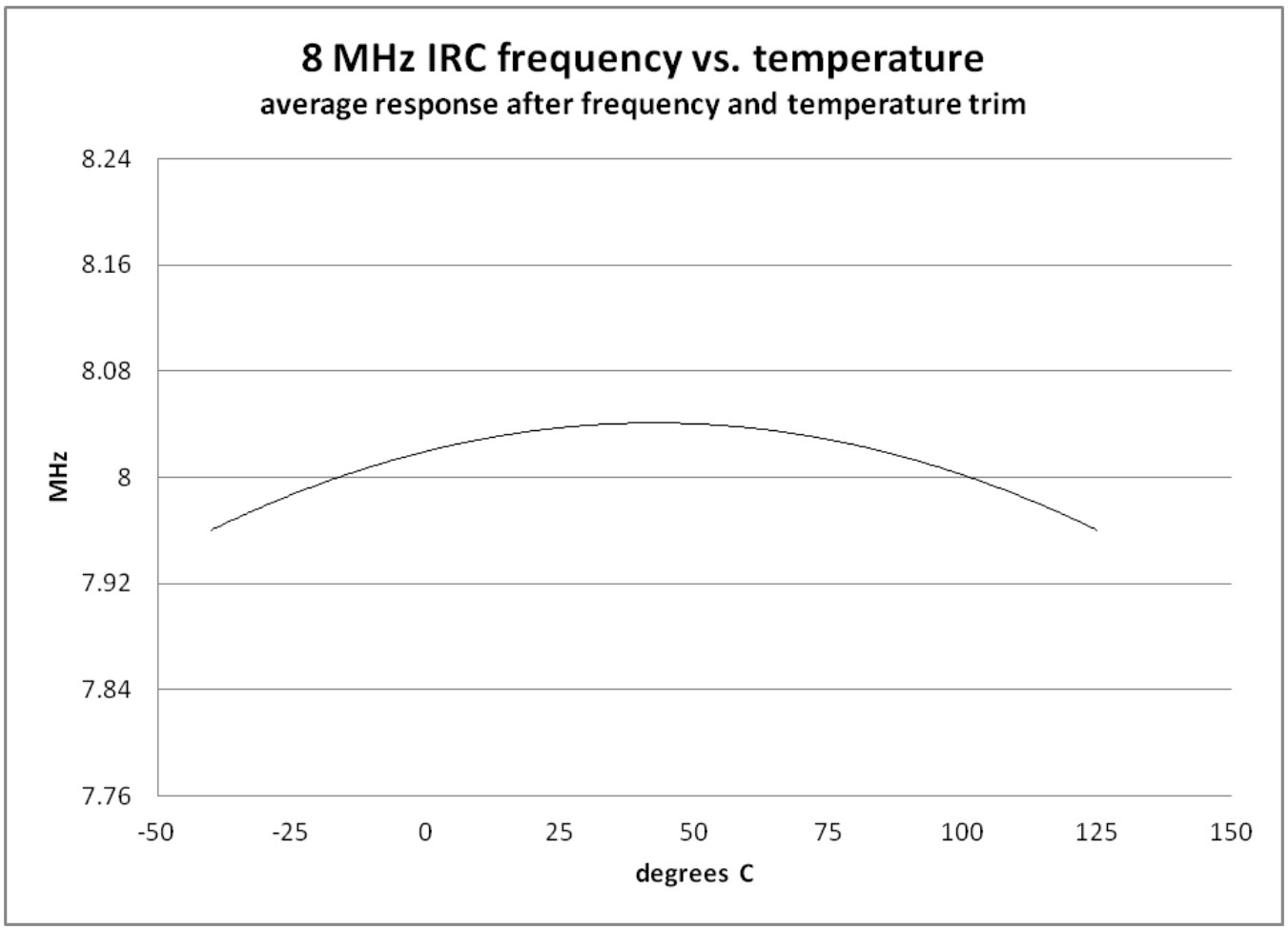

Figure 8. Relaxation Oscillator Temperature Variation (Typical) After Trim (Preliminary)

8.4 Memories and memory interfaces

8.4.1 Flash Memory Characteristics

Table 22. Flash Timing Parameters

Characteristic	Symbol	Min	Typ	Max	Unit
Longword Program high-voltage time[1]	thvpgm4	—	63	143	µs
Sector Erase high-voltage time [2]	thversscr	—	13	113	ms
Erase Block high-voltage time for 256 KB	thversblk256k	—	52	452	ms

1. There is additional overhead that is part of the programming sequence. See the device Reference Manual for detail.
2. Specifies page erase time.

7. For guidelines and examples of conversion rate calculation, download the ADC calculator tool: http://cache.freescale.com/files/soft_dev_tools/software/app_software/converters/ADC_CALCULATOR_CNV.zip?fpsp=1

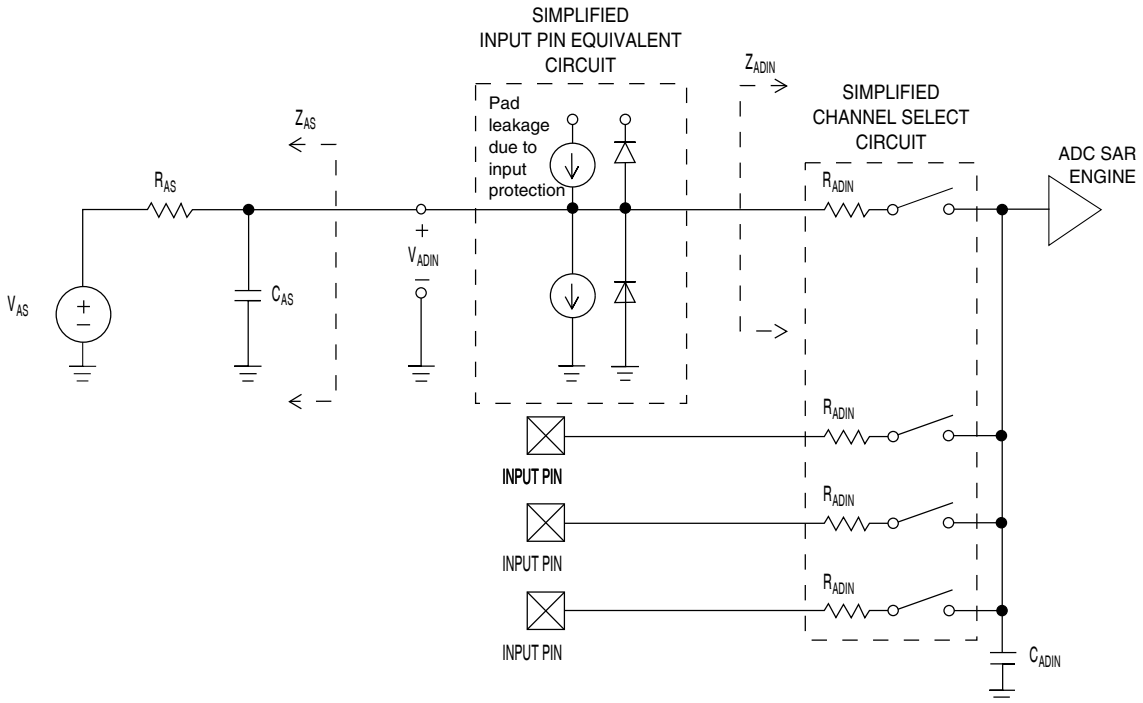

Figure 10. ADC input impedance equivalency diagram

8.5.2.2 16-bit ADC electrical characteristics

Table 27. 16-bit ADC characteristics ($V_{REFH} = V_{DDA}$, $V_{REFL} = V_{SSA}$)

Symbol	Description	Conditions[1]	Min.	Typ.[2]	Max.	Unit	Notes
I_{DDA_ADC}	Supply current			—	1.7	mA	3
f_{ADACK}	ADC asynchronous clock source	• ADLPC=1, ADHSC=0	1.2	2.4	3.9	MHz	$t_{ADACK} = 1/f_{ADACK}$
		• ADLPC=1, ADHSC=1	3.0	4.0	7.3	MHz	
		• ADLPC=0, ADHSC=0	2.4	5.2	6.1	MHz	
		• ADLPC=0, ADHSC=1	4.4	6.2	9.5	MHz	
	Sample Time	See Reference Manual chapter for sample times					
TUE	Total unadjusted error	• 12 bit modes	—	±4	±6.8	LSB[4]	5
		• <12 bit modes	—	±1.4	±2.1		
DNL	Differential non-linearity	• 16 bit modes	—	-1 to +4		LSB[4]	5
		• 12 bit modes	—	±0.7	TBD		
		• <12 bit modes	—	±0.2	-0.3 to 0.5		
INL	Integral non-linearity	• 16 bit modes	—	±7.0		LSB[4]	5
		• 12 bit modes	—	±1.0	-2.7 to +1.9		
		• <12 bit modes	—	±0.5	-0.7 to +0.5		

Table continues on the next page...

3. The ADC supply current depends on the ADC conversion clock speed, conversion rate and the ADLPC bit (low power). For lowest power operation the ADLPC bit should be set, the HSC bit should be clear with 1MHz ADC conversion clock speed.
4. 1 LSB = $(V_{REFH} - V_{REFL})/2^N$
5. ADC conversion clock <16MHz, Max hardware averaging (AVGE = %1, AVGS = %11)
6. Input data is 100 Hz sine wave. ADC conversion clock <12MHz.
7. Input data is 1 kHz sine wave. ADC conversion clock <12MHz.
8. System Clock = 4 MHz, ADC Clock = 2 MHz, AVG = Max, Long Sampling = Max

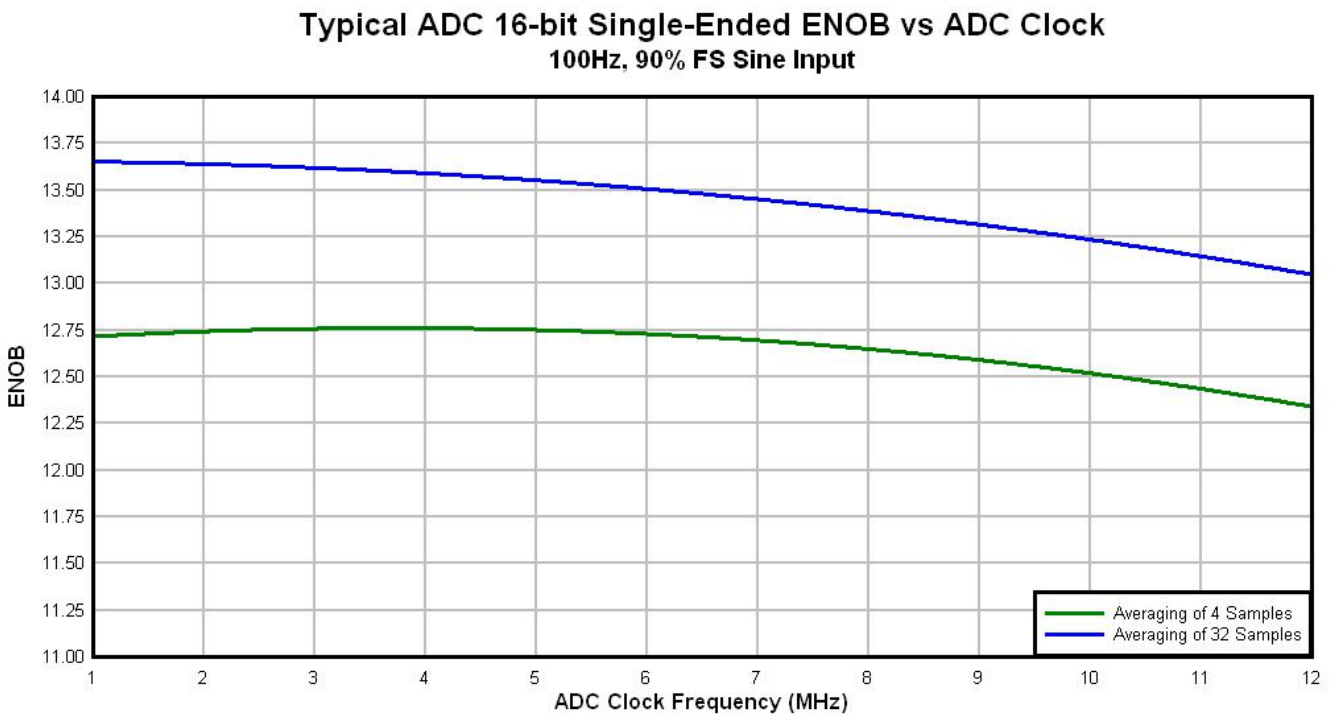

Figure 11. Typical ENOB vs. ADC_CLK for 16-bit single-ended mode

8.5.3 12-bit Digital-to-Analog Converter (DAC) Parameters

Table 28. DAC Parameters

Parameter	Conditions/Comments	Symbol	Min	Typ	Max	Unit
DC Specifications						
Resolution			12	12	12	bits
Settling time[1]	At output load RLD = 3 kΩ CLD = 400 pf		—	1		µs
Power-up time	Time from release of PWRDWN signal until DACOUT signal is valid	t_{DAPU}	—	—	11	µs
Accuracy						

Table continues on the next page...

Table 31. Timer Timing

Characteristic	Symbol	Min[1]	Max	Unit	See Figure
Timer input period	P_{IN}	2T + 6	—	ns	Figure 14
Timer input high/low period	P_{INHL}	1T + 3	—	ns	Figure 14
Timer output period	P_{OUT}	33	—	ns	Figure 14
Timer output high/low period	P_{OUTHL}	16.7	—	ns	Figure 14

1. T = clock cycle. For 60 MHz operation, T = 16.7 ns.

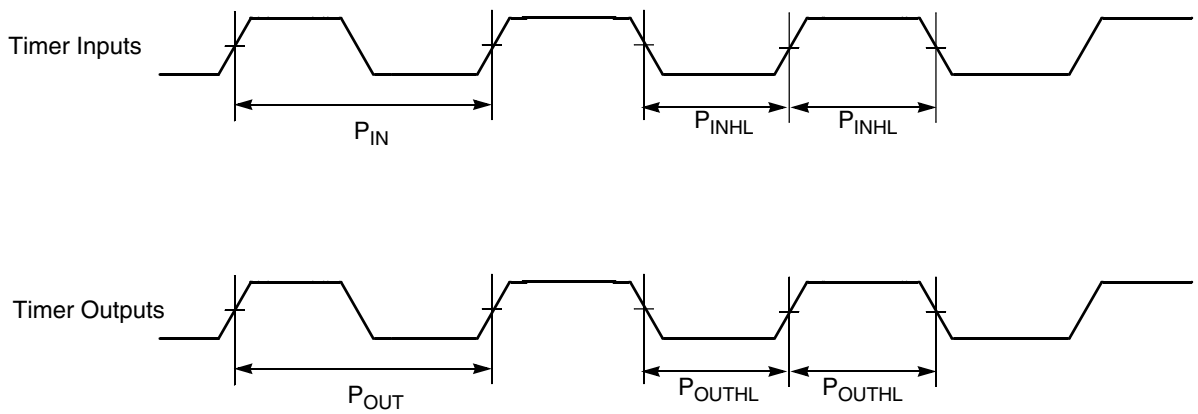

Figure 14. Timer Timing

8.7 Communication interfaces

8.7.1 Queued Serial Peripheral Interface (SPI) Timing

Parameters listed are guaranteed by design.

Table 32. SPI Timing

Characteristic	Symbol	Min	Max	Unit	See Figure
Cycle time	t_C				Figure 15
Master		55	—	ns	Figure 16
Slave		55	—	ns	Figure 17
					Figure 18
Enable lead time	t_{ELD}				Figure 18
Master		—	—	ns	
Slave		17.5	—	ns	
Enable lag time	t_{ELG}				Figure 18
Master		—	—	ns	
Slave		17.5	—	ns	

Table continues on the next page...

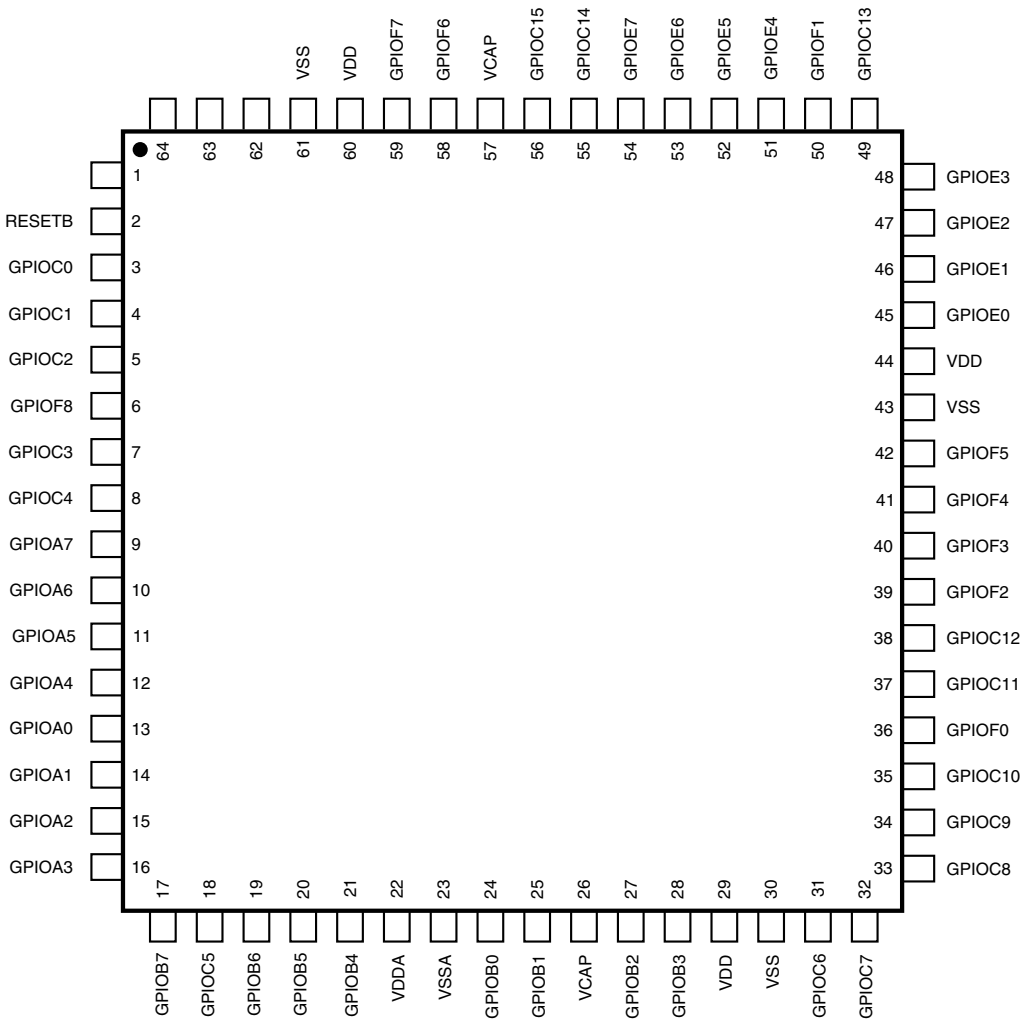

Figure 23. 64-pin LQFP

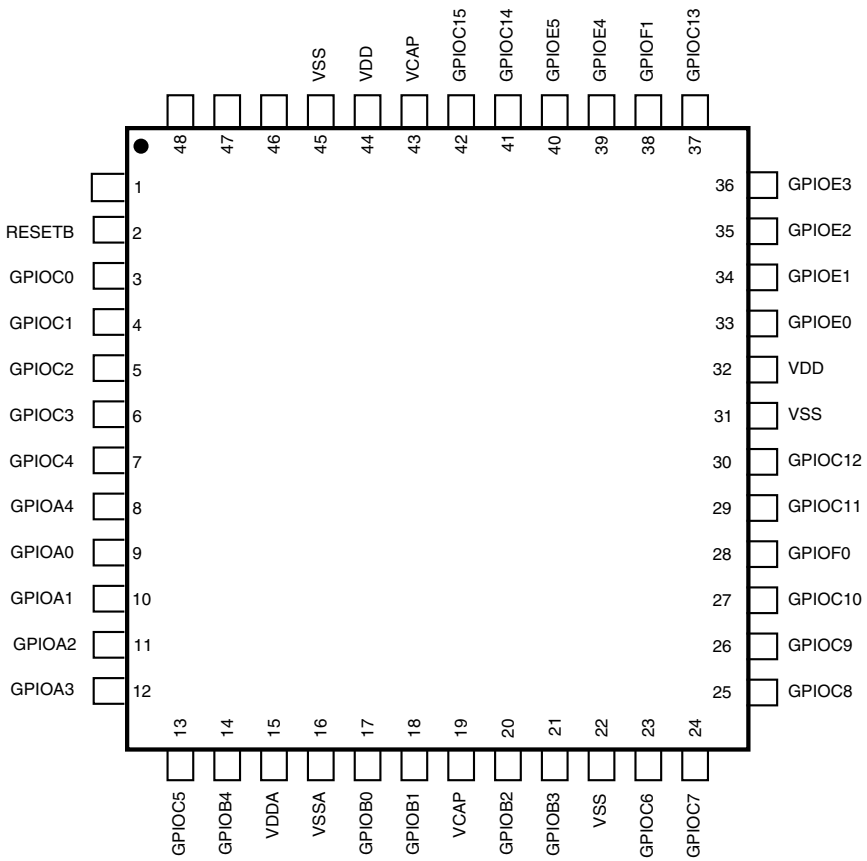

Figure 24. 48-pin LQFP

12 Product Documentation

The documents listed in Table 36 are required for a complete description and proper design with the device. Documentation is available from local Freescale distributors, Freescale Semiconductor sales offices, or online at http://www.freescale.com.

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